Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/479,999	NAKAMURA ET AL.
Examiner	Art Unit
Cong-Lac Huynh	2178

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	513	11/1/2005	CLH
	501.1	11/1/2005	CLH
	517	11/1/2005	CLH
	526	11/1/2005	CLH
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

(INCLUDIN	EARCH NOTES G SEARCH STRATEGY)
	DATE	EXMR
East	11/1/2005	CLH
ACM	11/1/2005	CLH
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